

**Search Notes**

Application/Control No.

10/526,494

Examiner

Jacob Cheu

Applicant(s)/Patent under  
Reexamination

MATSUURA, EIJI

Art Unit

1641

**SEARCHED**

Class	Subclass	Date	Examiner
435	7.1	12/2/2007	JC
	7.2		
	7.91		
530	387		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST STIC Inventor Search	12/2/2007	JC